

SI7135DP-T1-GE3-VB Datasheet P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|-------------------------------------|--------------------|-----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) | Q _g (Typ.) | | | |
| - 30 | 0.0032 at V _{GS} = - 10 V | - 100 | 78 nC | | | |
| - 30 | 0.0050 at V _{GS} = - 4.5 V | - 80 | 70110 | | | |

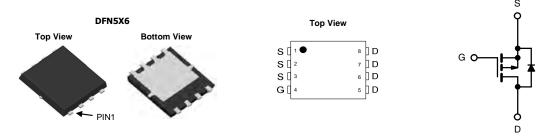
FEATURES

- Halogen-free
- Trench Power MOSFET
- 100 % R_g Tested



APPLICATIONS

- Notebook
 - Load Switch



P-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS | T _A = 25 °C, unles | ss otherwise note | ed | | |
|-----------------------------------------------------|-----------------------------------|-------------------|------------------------|-----------------------------------------|--|
| Parameter | Symbol | Limit | Unit | | |
| Drain-Source Voltage | VDS | - 30 | V | | |
| Gate-Source Voltage | V _{GS} | ± 20 | v | | |
| | T _C = 25 °C | | - 100 | | |
| Continuous Drain Current (T _{.I} = 150 °C) | T _C = 70 °C | I _D | - 75 | | |
| Sommada Brain Garretti (1j = 100 °C) | T _A = 25 °C | υ | - 31.6 ^{b, c} | | |
| | T _A = 70 °C | | - 25.3 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | - 300 | ^ | |
| Continuous Source-Drain Diode Current | $T_C = 25 ^{\circ}C$ | I _S | - 60 ^a | | |
| Continuous Source-Diam Blode Current | T _A = 25 °C | 'S | - 5.6 ^{b, c} | | |
| Single Pulse Avalanche Current L = 0.1 mH | | I _{AS} | - 40 | | |
| Single Pulse Avalanche Energy | L = 0.1 11111 | E _{AS} | 80 | mJ | |
| | $T_C = 25 ^{\circ}C$ | | 104 | | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 66.6 | w | |
| Maximum Tower Dissipation | T _A = 25 °C | , п | 6.25 ^{b, c} | • • • • • • • • • • • • • • • • • • • • | |
| | T _A = 70 °C | | 4.0 ^{b, c} | | |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 150 | °C | | |
| Soldering Recommendations (Peak Temperature | | 260 | | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|---------------------------------------------|--------------|-------------------|---------|------|-------|--|--|
| Parameter | Symbol | Typical | Maximum | Unit | | | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 10 s | R _{thJA} | 15 | 20 | °C/W | | |
| Maximum Junction-to-Case (Drain) | Steady State | R _{thJC} | 0.9 | 1.2 | O/ VV | | |

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

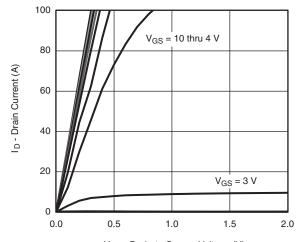


| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|-----------------------------------------------|----------------------------------|-------------------------------------------------------------------------------------|-------|--------|-------|-------|
| Static | | | | , , | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | - 30 | | | V |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | J 050 A | | - 31 | | 14/00 |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = - 250 μA | | 6.5 | | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | - 1.0 | | - 3.0 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA |
| | | V _{DS} = - 30 V, V _{GS} = 0 V | | | - 1 | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$ | | | - 10 | μΑ |
| On-State Drain Current ^a | I _{D(on)} | V _{DS} = - 5 V, V _{GS} = - 10 V | - 30 | | | Α |
| | Б | V _{GS} = - 10 V, I _D = - 20 A | | 0.0032 | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 4.5 V, I _D = - 15 A | | 0.005 | | Ω |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 15 V, I _D = - 20 A | | 95 | | S |
| Dynamic ^b | | | | | | |
| Input Capacitance | C _{iss} | | | 8650 | | |
| Output Capacitance | C _{oss} | V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz | | 1215 | | pF |
| Reverse Transfer Capacitance | C _{rss} | | | 1125 | | |
| Total Gate Charge | Qg | V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 20 A | | 167 | 250 | nC |
| | | | | 78 | 120 | |
| Gate-Source Charge | Q_{gs} | $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$ | | 27 | | |
| Gate-Drain Charge | Q_{gd} | | | 35 | | |
| Gate Resistance | R_{g} | f = 1 MHz | | 1.7 | | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 25 | 40 | |
| Rise Time | t _r | V_{DD} = - 15 V, R_L = 15 Ω | | 15 | 30 | ns |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong$ - 1.0 A, V_{GEN} = - 10 V, R_g = 1 Ω | | 110 | 170 | |
| Fall Time | t _f | | | 30 | 50 | |
| Turn-On Delay Time | t _{d(on)} | | | 110 | 170 | |
| Rise Time | t _r | V_{DD} = - 15 V, R_L = 15 Ω | | 100 | 150 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong$ - 1.0 A, $V_{GEN}=$ - 4.5 V, $R_g=$ 1 Ω | | 100 | 150 | |
| Fall Time | t _f | | | 50 | 75 | |
| Drain-Source Body Diode Characteristi | cs | | | " | | |
| Continuous Source-Drain Diode Current | I _S | $T_C = 25 ^{\circ}C$ | | | 60 | ٨ |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 100 | A |
| Body Diode Voltage | V _{SD} | I _S = - 5 A | | - 0.74 | - 1.1 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 50 | 100 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 3.5 A, dI/dt = 100 A/μs, T _{.I} = 25 °C | | 65 | 130 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = 3.3 \text{ A}, \text{ u/ul} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ C}$ | | 26 | | |
| Reverse Recovery Rise Time | t _b | t _b | | 24 | | ns |

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

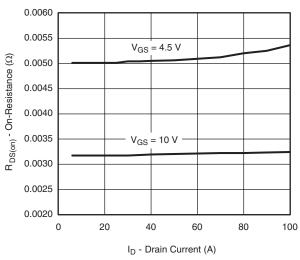
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



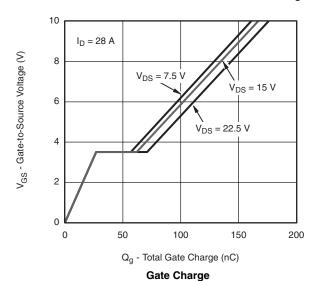


V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

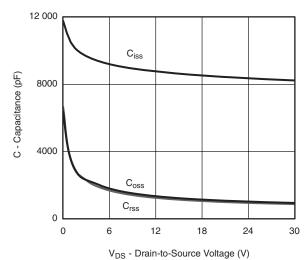


On-Resistance vs. Drain Current and Gate Voltage

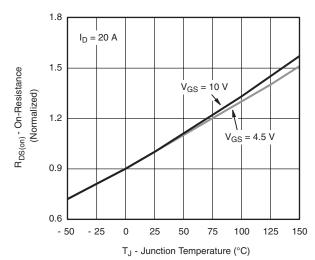


1.2 1.0 T_C = - 55 °C I_D - Drain Current (A) 0.8 0.6 T_C = 25 °C 0.4 0.2 T_C = 125 °C 0.0 0.0 0.5 1.5 3.0 V_{DS} - Drain-to-Source Voltage (V)

Transfer Characteristics

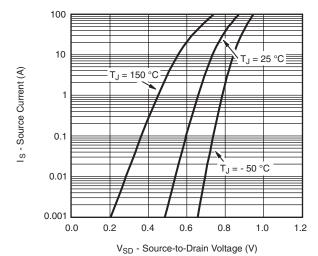


Capacitance

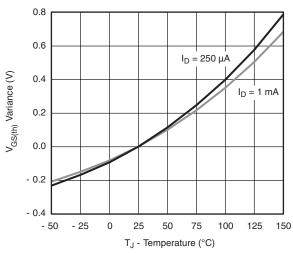


On-Resistance vs. Junction Temperature



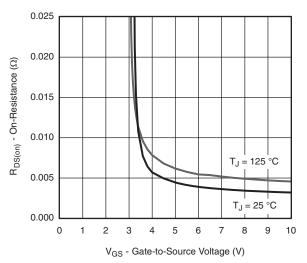


Source-Drain Diode Forward Voltage

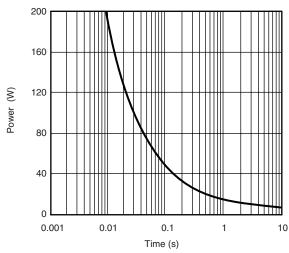


Threshold Voltage

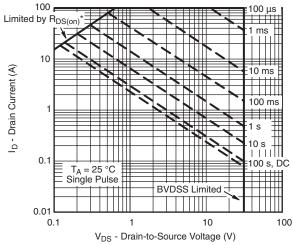
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On-Resistance vs. Gate-to-Source Voltage



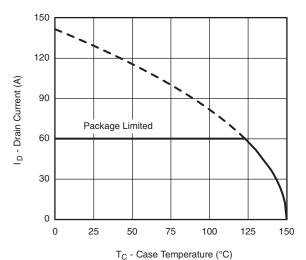
Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

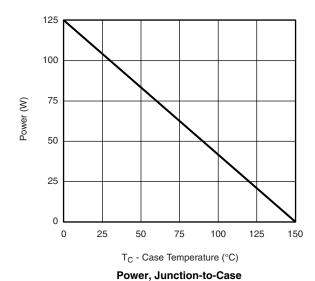
Safe Operating Area, Junction-to-Ambient

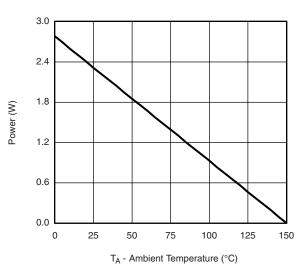




- C - Case Temperature (C)

Current Derating*

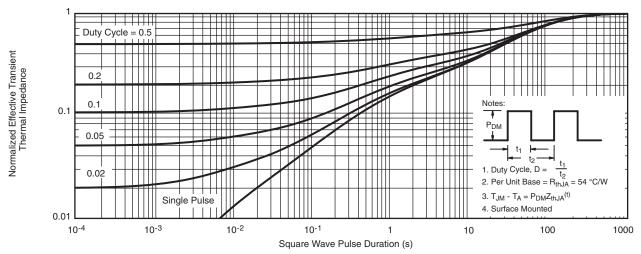




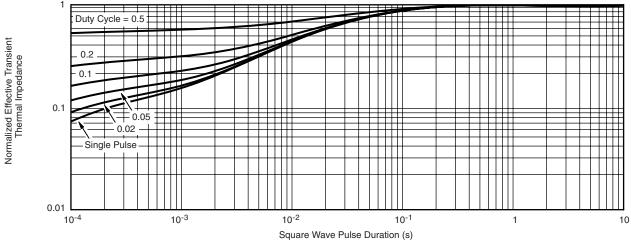
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





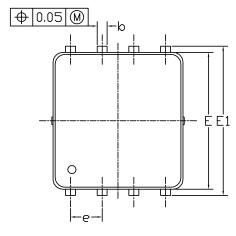
Normalized Thermal Transient Impedance, Junction-to-Ambient

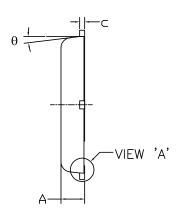


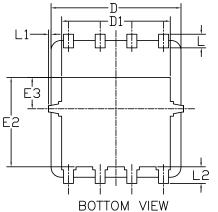
Normalized Thermal Transient Impedance, Junction-to-Case

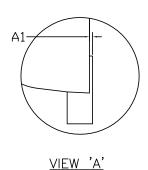


DFN5x6_8L_EP1_P PACKAGE OUTLIN



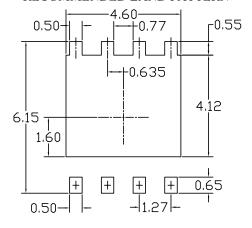






(SCALE 5:1)

RECOMMENDED LAND PATTERN



| CAN ADOL C | DIMENSIONS IN MILLIMETERS | | | DIMENSIONS IN INCHES | | | |
|------------|---------------------------|--------|--------|----------------------|--------|--------|--|
| SYMBOLS | MIN | NOM | MAX | MIN | NOM | MAX | |
| A | 0.85 | 0. 95 | 1.00 | 0.033 | 0.037 | 0.039 | |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 | |
| b | 0.30 | 0.40 | 0.50 | 0.012 | 0.016 | 0.020 | |
| c | 0. 15 | 0. 20 | 0. 25 | 0.006 | 0.008 | 0.010 | |
| D | 5. 10 | 5. 20 | 5. 30 | 0. 201 | 0. 205 | 0. 209 | |
| D1 | 4. 25 | 4. 35 | 4.45 | 0. 167 | 0.171 | 0. 175 | |
| Е | 5. 45 | 5. 55 | 5. 65 | 0. 215 | 0. 219 | 0. 222 | |
| E1 | 5. 95 | 6.05 | 6. 15 | 0. 234 | 0. 238 | 0. 242 | |
| E2 | 3. 525 | 3.625 | 3. 725 | 0. 139 | 0. 143 | 0. 147 | |
| E3 | 1. 175 | 1. 275 | 1. 375 | 0.046 | 0.050 | 0.054 | |
| e | 1. 27 BSC | | | 0. 050 BSC | | | |
| L | 0.45 | 0. 55 | 0.65 | 0.018 | 0.022 | 0.026 | |
| L1 | 0 | | 0.15 | 0 | | 0.006 | |
| L2 | 0.68 REF | | | 0.027 REF | | | |
| θ | 0° | | 10° | 0° | | 10° | |

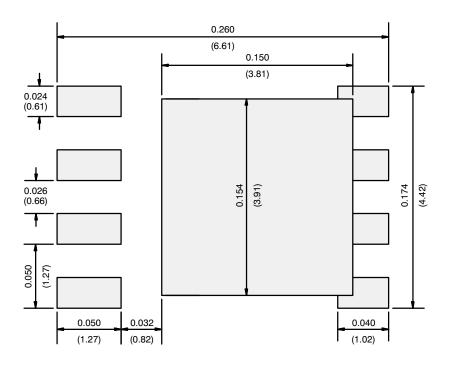
NOTE

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



RECOMMENDED MINIMUM PADS FOR DFN5 x 6



Recommended Minimum Pads Dimensions in Inches/(mm)



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